The effect of the difference time grinding on the structure and morphology of Aluminum Oxide (Al₂O₃)

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ABSTRACT. The objective of the paper has been given on the observations based on the studies on aluminum oxide (Al₂O₃) powder or alumina for different time grinding. A discussion about simple and low cost preparation of Al₂O₃ powder by (Mini Mill 2 Panalytical) and preparation of the sample was rotating at 0, 5, 10 and 15 min and in the case of grinding of samples at high speed 659 rpm. Structure and morphology of aluminum oxide (Al₂O₃) powder its characterizations (XRD (Model: Panalytical Empyrean) and STM (Model: NTMDT Solver Nano.)) are studied in this research paper.

1. INTRODUCTION

Alumina (Al₂O₃) shows excellent physical and chemical properties, including the highest strength among oxides, excellent abrasion resistance, heat resistance, a high dielectric strength at high voltage, and high resistance to chemical attack [9-11]. X-ray diffraction is one of the most powerful tools for identifying unknown crystalline phases [14]. By comparing the positions and intensities of the diffraction peaks against a library of known crystalline materials, the test sample can be identified [18]. The powder metallurgy route for manufacturing composites materials offers some advantages compared with ingot metallurgy or diffusion welding. Alumina powder is a commonly used raw material in support preparation processes [2-4]. Al₂O₃ is the most stable type among various crystal phases because of its high lattice energy, high hardness, hard ground, and easy agglomeration [6-15]. The crystalline phase and average crystallite size of the powder were determined by X-ray diffraction (XRD) [1-3]. A scanning tunneling microscope (STM) was used to investigate the roughness and morphology. The STM analyses the surface of alumina, producing images of higher resolution.

2. SAMPLE PREPARATION BY MINI MILL 2 PANALYTICAL

Before grinding aluminum oxide powder by Minimill 2 was cleaned the bowl with acetone for a short time [5]. The hardness of the grinding bowl used and of the grinding balls must be higher than of the Al₂O₃ used. The grinding bowls and grinding balls of aluminum oxide are resistance to acids with the exception of hydrofluoric acid. In accordance with the application, the grinding time should be adapted of the bowl. Al₂O₃ powders have investigated different time 0, 5, 10 and 15 min and in the case of grinding for all samples at high speed 659 rpm.

3. X-RAY DIFFRACTION STUDY OF ALUMINUM OXIDE (Al₂O₃)

X-ray diffraction is one of the most important characterization tools used in solid state chemistry and materials science [7-13]. XRD is an easy tool to determine the size and the shape of the unit cell for any compound. XRD used to determine peak position was carried out using a Panalytical. Cu X-ray tube (λ = 0.15406 nm) equipped with a 1x1 mm² point focus and a Nickel
filter on the direct beam path to absorb the Cu K$_{ß}$ radiation. The incident beam is collimated with a 1mm. Diameter collimator and focused on the sample mounted on a four-circle goniometer [10-16]. X-ray diffraction patterns of grain as shown in the fig.1 and different time Al$_2$O$_3$ powder. Figure 2 also shows that under the same applied different grinding time for the position 2θ between 34º and 39º.

![XRD pattern](image)

**Fig.1.** Variation of time grinding x-ray diffraction patterns of Al$_2$O$_3$.

The XRD quantitative analysis for measuring crystallite size and determining alumina phase concentrations, a quantitative analysis of diffractogram patterns for each sample including crystallite sizes and concentration of alumina phases formed was applied and assisted using XRD software. The average crystallite size was calculated using the Debye-Scherrer formula [3-5]:

$$D = \frac{0.9\lambda}{\beta \cos \theta}$$  

(1)

Where ‘$\lambda$’ is wave length of X-Ray (1.5406Å), ‘$\beta$’ is FWHM (full width at half maximum), ‘$\theta$’ is the diffraction angle and ‘$D$’ is is the crystallite size.

XRD analysis of the prepared sample of alumina or aluminum oxide powder was done by a Panalytical (Under 45kV/40mA - X-Ray, 20/0-Scanning mode). Data was taken for the 2θ range of 5 to 90 degrees with a step of 0.013 degree.

The XRD patterns of the aluminum oxide peaks at 2θ angles values approximately of 26.35, 35.44, 37.54, 44.14, 53.30, 58.22, 61.94, 67.25, 68.87 and 77.52 deg corresponding to the (012), (104), (110), (113), (202), (024), (116), (018), (214) and (1010) planes of aluminum oxide were observed and compared with the standard powder diffraction [8-12].

For studied samples the preferential orientation value of (104) plane has the highest value compared to other planes. The obtained result indicates a strong orientation along the (104) plane. Based on the line width of the (104) diffraction peak, the crystalline grain size for the Al$_2$O$_3$ with differing times grinding as shown in Fig. 2, and the intensity for all peaks decreasing with increasing times grinding by (Mini Mill 2 Panalytical).
Fig. 2. Difference time grinding aluminum oxide powder by XRD at 2θ = 34º - 39º.

The crystallite size (D) increase with increasing times grinding by (Mini-Panalytical) and the maximum value D at t = 15 min. as shown in the table (1).

Table 1. The grain size increase with increasing times grinding.

<table>
<thead>
<tr>
<th>t</th>
<th>D(Å)</th>
</tr>
</thead>
<tbody>
<tr>
<td>0 min</td>
<td>671.98</td>
</tr>
<tr>
<td>5 min</td>
<td>851.66</td>
</tr>
<tr>
<td>10 min</td>
<td>1180.34</td>
</tr>
<tr>
<td>15 min</td>
<td>1578.32</td>
</tr>
</tbody>
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4. SCANNING TUNNELING MICROSCOPIC (STM)

The STM provides real space atomic resolution images through tunneling current between a tip (Pt-Ir) and an aluminum oxide surface [5]. Characterized for their crystal structure and surface morphology [17]. The surface roughness was measured by using STM. Shows the surface morphology of different times 5 min, 10 min and 15 min as shown in Fig. 3. From STM images it was found that the root mean square roughness with 500 x 500 points, and scanning rate of 0.8 Hz, applied voltage 2.14 nV and the current between surface iron metallic and tip was 5.0 nA.

Fig. 3. STM image of surface aluminum oxide of 2D at (a) t = 5 min (b) t = 10 min (c) t = 15 min.

5. RESULT AND CONCLUSION

The XRD study confirms / indicates that the resultant particles are (Al₂O₃) by diffraction pattern presented in the Fig. 1. To investigation of the different time grinding of the peaks Al₂O₃ by XRD, the increasing time of grinding samples affect to decrease the intensity of the peaks Al₂O₃. Show the double peak visible at the position 35º and 36º also the peak is shift of the origin position. The crystallite size (D) increase with increasing times grinding by (Mini-Panalytical) as shown in
the table (1). Also the effect of the grinding time on the image topography STM, to surfaces of the products of $\text{Al}_2\text{O}_3$ were obviously smooth. The evaluated root mean square (RMS) surface roughness of the samples at $t=5$ min was RMS = 3.07 nm, $t=10$ min was RMS = 2.45 nm and $t=15$ min was RMS = 1.58 nm, as seen in the Fig.3.

References


